

Search Notes



Application/Control No.

10/824,307

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

CHOU ET AL.

Art Unit

2187

SEARCHED

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Class	Subclass	Date	Examiner
711	137	9/26/2006	HN
	117	} text search using EAST	
	118		
updated above using EAST			
		4/19/07	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search his. is attached	9/26/2006	HN
NPL Search using terms similar to EAST search.	9/26/2006	HN
Inventorship search	9/26/2006	HN